## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/585,310	Reexamination NAKAMURA, MIT	suo
Examiner	Art Unit	
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### II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-1,769,546 A	07-1930	RITCHEY ROSCOE V	198/617
*	В	US-2,932,379 A	04-1960	RIZO RANGABE ALEXANDER	198/617
*	O	US-3,389,662 A	06-1968	JACOBY CHARLES E	104/172.5
*	D	US-3,888,717 A	06-1975	Koyama et al.	156/351
*	Е	US-3,921,795 A	11-1975	Vandale et al.	198/382
*	F	US-4,234,371 A	11-1980	Christman, Harold E.	156/96
*	G	US-4,262,794 A	04-1981	Bourgeois, Ronald D.	198/459.8
*	Н	US-4,807,525 A	02-1989	de Brock, Raoul	100/153
*	-	US-4,821,869 A	04-1989	Hodlewsky, William G.	198/779
*	J	US-5,846,475 A	12-1998	Yano et al.	264/444
*	К	US-5,853,783 A	12-1998	Rijkaart, Cornelis	426/496
*	L	US-5,901,854 A	05-1999	Ishii, Toru	209/538
*	м	US-6,016,903 A	01-2000	Lochbrunner, Johann	198/370.1

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
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### NON-PATENT DOCUMENTS

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# Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/585,310	Reexamination NAKAMURA, MIT	SUO
Examiner	Art Unit	
SEAN M. MICHALSKI	3724	Page 2 of 2

### U.S. PATENT DOCUMENTS

	oldi i i i i i i i i i i i i i i i i i i				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,050,196 A	04-2000	Matsushita et al.	104/172.3
*	В	US-6,109,421 A	08-2000	Ross et al.	198/457.07
*	С	US-6,148,989 A	11-2000	Ecker, Peter M.	198/387
*	D	US-6,152,854 A	11-2000	Carmein, David E. E.	482/4
*	Е	US-6,398,015 B1	06-2002	Sedlacek et al.	198/779
*	F	US-7,040,480 B2	05-2006	Sedlacek, Kyle J.	198/457.02
*	G	US-7,357,240 B2	04-2008	Ogimura et al.	198/330
*	Н	US-7,426,992 B2	09-2008	Fourney, Matthew L.	198/779
*	Т	US-7,506,750 B2	03-2009	Costanzo et al.	198/779
*	J	US-2009/0090599 A1	04-2009	Fourney, Matthew L.	198/345.3
*	К	US-2009/0200139 A1	08-2009	Kissee et al.	198/415
	L	US-			
	м	us-			

### FOREIGN PATENT DOCUMENTS

TOKEIGH TATEHT BOOMERTO						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	т					

NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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